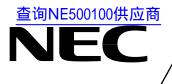
PRELIMINARY DATA SHEET



# GaAs MES FET NE85001 SERIES

### 1 W C-BAND POWER GaAs FET N-CHANNEL GaAs MES FET

#### DESCRIPTION

The NE8500199 Power GaAs FET covers 2 GHz to 10 GHz frequency range for commercial amplifier, oscillator applications and so on.

NE8500100 is the two-cells recessed gate chip used in '99' package.

The device incorporates Ti-Al gate and silicon dioxide glassivation. To reduce the thermal resistance, the device has a PHS. (Plated Heat Sink)

NEC's strigent quality assurance and test procedures assure the highest reliability and performance.

PERFORMANCE SPECIFIED

GL (\*\*)

(dB)

9.0 typ

9.0 typ

#### FEATURES

- Class A operation
- High power output
- High reliability

PART NUMBER

NE8500100(\*)

NE8500100-WB

NE8500100-RG

#### SELECTION CHART

PHYS	ICAL	DIME	INSIO	NS
	400 10		1	

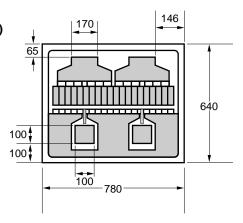
NE8500100 (CHIP) (unit: μm)

USABLE

FREQUENCY

(GHz)

2.0 to 10



#### PACKAGE CODE-99 (unit: mm)

\* WB, RG indicate a type of containers for chips.
WB: black carrier, RG: ring,: gel-pack,

Pout (\*\*)

(dBm)

28.5 min

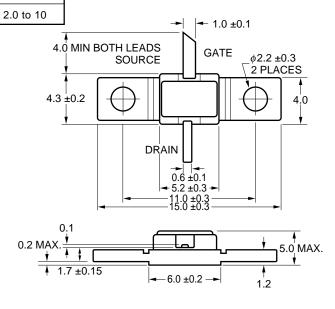
28.5 min

\*\* Specified at the condition at the last page.

FORM

chip

package



#### ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25 $^{\circ}$ C)

Drain to Source Voltage	Vdsx	15	V
Gate to Drain Voltage	Vgdx	-18	V
Gate to Source Voltage	Vgsx	-12	V
Total Power Disipation(*)	Р⊤	6.0	W
Drain Current	ld	1.12	А
Gate Current	lg	6.0	mA
Channel Temperature	Tch	175	С
Storage Temperature	Tstg	-65 to 175	С
			*Tc = 25 °C

#### **RECOMMENDING OPERATION RANDGE**

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT
Drain to Source Voltage	Vds	9	-	10	V
Channel Temperature	Tch	-	-	130	°C
Input Power	Gcomp	-	-	3	dBcomp
Gate Resistance	Rg	-	-	1	kΩ

#### ELECTRICAL CHARACTERISTICS ( $T_A = 25$ °C)

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Saturated Drain Current	ldss	430	-	860	mA	Vds = 2.5 V, Vgs = 0 V
Pinch-off Voltage	VP	-3.0	-	-1.0	V	Vds = 2.5 V, Ids = 4 mA
Transconductance	gm	-	300	_	mS	Vds = 2.5 V, Ids = Idss
Thermal Resistance	Rth	-	-	30	°C/W	

#### PERFORMANCE SPECIFICATIONS ( $T_A = 25$ °C)

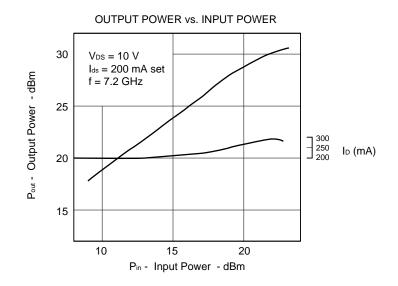
PART NUMBER		NE8500100 NE8500100-WG NE8500100-RG			NE8500199			UNIT	TEST CONDITIONS
PACKAGE CODE		CHIP			99				
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.		
Output Power	Po	28.5	_	-	28.5	-	_	dBm	f = 7.2 GHz Vds = 10 V Ids = 200 mA set
Gate to source Current	lgs	-2.0	-	2.0	-2.0	-	2.0	mA	Rg = 1 kΩ Pin = 21.0 dBm(*)
Linear Gain	G∟	-	9	-	-	9	-	dB	Pin ≤ 11 dBm (**)

\* Pin for Pout specification.

\*\* The same conditions as the above except this.

#### TYPICAL CHARACTERISTICS (T<sub>A</sub> = 25 $^{\circ}$ C)

#### NE8500199



## NEC

#### S-PARAMETER

Vds = 10 V, Ids = 200 mA, Vds = -1.260 V, Id = 0.0 mA, Rd = 1  $k\Omega$ 

FREQUENCY S11		11	S	21	S	12	S	<b>S</b> 22		
GHz	MAG	ANG	MAG	ANG	MAG	ANG	MAG	ANG		
0.100	0.990	-22.7	14.418	165.5	0.007	70.1	0.065	-64.6		
0.500	0.916	-91.1	10.211	123.3	0.024	47.7	0.175	-126.4		
1.000	0.869	-132.1	6.444	94.8	0.031	33.6	0.221	-149.1		
1.500	0.851	-152.9	4.610	76.6	0.034	29.0	0.241	-159.2		
2.000	0.840	-166.1	3.591	61.9	0.038	28.1	0.260	-165.6		
2.500	0.831	-175.9	2.975	49.1	0.042	26.7	0.278	-170.8		
3.000	0.826	176.0	2.601	37.3	0.047	25.4	0.296	-174.6		
3.500	0.824	168.8	2.341	26.0	0.053	27.4	0.313	-177.8		
3.600	0.825	167.5	2.291	23.4	0.055	27.0	0.317	-179.2		
3.700	0.825	166.0	2.253	20.7	0.056	26.5	0.323	179.8		
3.800	0.827	164.4	2.230	18.1	0.059	26.8	0.333	179.4		
3.900	0.829	162.8	2.187	16.1	0.063	26.5	0.340	178.7		
4.000	0.829	161.0	2.127	13.4	0.066	25.4	0.345	176.3		
4.200	0.821	157.2	2.053	8.6	0.072	20.1	0.353	171.0		
4.400	0.808	153.9	1.976	5.6	0.074	16.8	0.343	167.3		
4.500	0.803	152.5	1.963	3.4	0.075	15.2	0.337	166.2		
4.600	0.799	151.0	1.970	0.8	0.077	13.9	0.340	164.8		
4.800	0.790	147.9	1.944	-3.1	0.080	12.6	0.341	163.2		
5.000	0.784	144.7	1.929	-8.6	0.084	9.3	0.340	159.8		
5.200	0.777	141.4	1.923	-12.8	0.089	7.4	0.349	158.6		
5.400	0.771	137.7	1.897	-18.5	0.093	4.5	0.347	155.6		
5.500	0.767	135.9	1.916	-20.7	0.097	3.1	0.358	154.2		
5.600	0.764	133.9	1.916	-22.7	0.100	1.8	0.363	154.5		
5.800	0.758	130.1	1.887	-28.5	0.105	-1.9	0.358	151.6		
6.000	0.751	125.8	1.928	-33.5	0.113	-4.8	0.381	149.5		
6.200	0.742	121.3	1.896	-39.1	0.116	-8.0	0.369	146.8		
6.400	0.731	116.6	1.951	-44.8	0.126	-11.6	0.397	144.2		
6.500	0.726	114.1	1.951	-47.2	0.130	-13.2	0.396	144.2		
6.600	0.721	111.6	1.936	-50.6	0.133	-15.9	0.387	141.8		
6.800	0.707	106.1	1.973	-56.8	0.143	-20.4	0.411	138.6		
7.000	0.689	100.2	1.957	-62.4	0.149	-23.9	0.402	137.1		
7.200	0.676	93.9	2.004	-69.1	0.163	-28.9	0.424	133.8		
7.400	0.657	87.1	2.002	-74.9	0.171	-33.3	0.425	132.3		
7.500	0.649	83.4	2.013	-78.8	0.177	-36.8	0.431	129.4		
7.600	0.640	79.9	2.045	-82.4	0.185	-39.6	0.448	127.2		
7.800	0.621	71.8	2.042	-88.6	0.195	-45.0	0.452	123.8		
8.000	0.604	63.2	2.067	-96.6	0.206	-51.8	0.465	117.2		
8.200	0.590	53.4	2.078	-103.5	0.216	-57.8	0.478	112.7		
8.400	0.584	42.7	2.088	-112.0	0.227	-65.4	0.492	104.8		
8.500	0.577	37.0	2.102	-115.5	0.232	-68.0	0.500	102.7		
8.600	0.574	31.2	2.083	-119.1	0.237	-71.2	0.501	100.1		
8.800	0.570	18.8	2.088	-127.8	0.246	-78.3	0.519	93.0		
9.000	0.571	5.9	2.072	-135.7	0.253	-84.7	0.534	87.2		
9.200	0.583	-7.6	2.044	-144.6	0.264	-92.3	0.545	80.1		
9.400	0.599	-21.4	2.040	-153.1	0.274	-99.3	0.568	73.6		
9.500	0.611	-28.5	2.030	-157.9	0.277	-103.2	0.577	69.7		
9.600	0.619	-35.9	2.008	-162.9	0.281	-107.4	0.583	65.8		
9.800	0.631	-50.4	1.943	-173.2	0.284	-115.9	0.600	56.3		
10.000	0.631	-62.9	1.812	177.3	0.280	-123.6	0.587	47.0		

#### CHIP HANDLING

#### DIE ATTACHMENT

Die attach can be accomplished with a Au-Sn (300  $\pm$ 10 °C) performs in a forming gas environment. Epoxy die attach is not recommended.

#### BONDING

Gate and drain bonding wires should be minimum length, semi-hard gold wire (3 - 8 % elongation) 30 microns or less in diameter.

Bonding should be performed with a wedge tip that has a taper of approximately 15 %.

Die attach and bonding time should be kept to a minimum. As a general rule, the bonding operation should be kept within a 280  $^{\circ}$ C \_ 5 minute curve. If longer periods are required, the temperature should be lowered.

#### PRECAUTIONS

The user must operate in a clean, dry environment.

The chip channel is glassivated for mechanical protection only and does not preclude the necessity of a clean environment.

The bonding equipment should be periodically checked for sources of surge voltage and should be properly grounded at all times. In fact, all test and handling equipment should be grounded to minimize the possibilities of static discharge.

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Special: Transportation equipment (automobiles, trains, ships, etc.), traffic control systems, anti-disaster systems, anti-crime systems, safety equipment and medical equipment (not specifically designed for life support)

Specific: Aircrafts, aerospace equipment, submersible repeaters, nuclear reactor control systems, life support systems or medical equipment for life support, etc.

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